Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination FANG ET AL. Examiner | Art Unit | Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2003/0035471	02-2003	Pitsoulakis, George	375/222
*	В	US-2005/0027888	02-2005	Juszkiewicz, Henry E.	709/250
*	C	US-2003/0204611	10-2003	McCosh et al.	709/230
*	D	US-6,754,622	06-2004	Beser et al.	704/226
*	E	US-2002/0091813	07-2002	Lamberton et al.	709/223
*	F	US-6,507,869	01-2003	Franke et al.	709/224
*	G	US-6,760,767	07-2004	Miesbauer et al.	709/227
*	Н	US-2004/0139170	07-2004	Shen et al.	709/218
*	1	US-2004/0093619	05-2004	Cox, David	725/110
	J	US-			
	к	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	P					
	Q					
	R					
	S					
	Т				·-	

NON-PATENT DOCUMENTS

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
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	V						
	w						
	×						

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